Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/680,464	SMITH ET AL.
Examiner	Art Unit
Thinh T. Nauvon	3010

	SEAR	CHED	
Class	Subclass	Date	Examiner
257	17	7/1/2005	TTN
257	32	7/1/2005	TTN
257	295	7/2/2005	TTN
257	421	7/2/2005	TTN
257	422	7/2/2005	TTN
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INT	ERFERENC	FERENCE SEARCHED			
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
		DATE	EXMR	
EAST	7/1	1/2005	TTN	
EAST	7/2	2/2005	TTN	